LMC6035-Q1

LMC6035-Q1 車載用、低消費電力 2.7V 単一電源 CMOS オペアンプ

1 特長

- 車載アプリケーション向けに AEC-Q100 認証済み
 - 温度グレード 3:-40℃~+85℃、T_Δ
- 特に記述のない限り標準値
- 2.7V、3V、5V、15Vの性能を仕様規定
- 2kΩ および 600Ω 負荷について動作を規定
- 広い動作範囲:2.0V~15.5V
- 超低入力電流:20fA
- レールツーレールの出力スイング
 - 600Ω 時:2.7V で各レールから 200mV
 - 100kΩ 時:2.7V で各レールから 5mV
- 高い電圧ゲイン:126 dB
- 広い入力同相電圧範囲
 - -0.1V~+2.3V (V_S = 2.7V 時)
- 低歪:10kHz 時に 0.01%

2 アプリケーション

- フィルタ
- ハイインピーダンスのバッファまたはプリアンプ
- バッテリ動作の電子機器
- 医療用計測装置
- 車載用アプリケーション

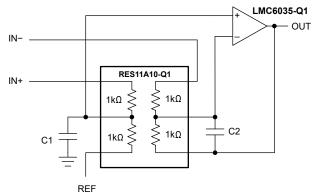
3 概要

LMC6035-Q1 は、600Ω 負荷でのレール ツー レール出 カスイングに対応できる安価な低電圧オペアンプです。ま た、これらのデバイスは、仕様で規定された 2.7V よりも低 い電源電圧でも正常に動作しますが、その場合、仕様より も多少性能が劣化します。この削減により、2.7V よりも大 幅に小さい電圧でも適切に動作する安全領域が得られま す。非常に低い入力電流 (I_R) を提供するため、これらの デバイスは低消費電力アクティブ フィルタ アプリケーショ ンに最適です。小さな IB により、より高い値の抵抗とより小 さい値のコンデンサが使えるためです。また、優れた駆動 能力を備えた LMC6035-Q1 というオペアンプは、低電圧 システムの幅広いアプリケーションに最適です。

パッケージ情報

部品番号	パッケージ ⁽¹⁾	パッケージ サイズ ⁽²⁾
LMC6035-Q1	D (SOIC, 8)	4.9mm × 6mm

- (1) 詳細については、セクション 10 を参照してください。
- (2) パッケージ サイズ (長さ×幅) は公称値であり、該当する場合はピ ンも含まれます。



RES11A を使った差動アンプのアプリケーション



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4 Pin Configuration and Functions

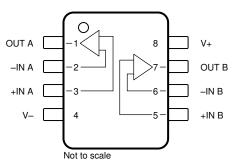


図 4-1. D Package, 8-Pin SOIC (Top View)

表 4-1. Pin Functions: D Package

	PIN	TYPE	DESCRIPTION
NAME	NO.	ITPE	DESCRIPTION
−IN A	2	Input	Inverting input channel A
–IN B	6	Input	Inverting input channel B
+IN A	3	Input	Noninverting input channel A
+IN B	5	Input	Noninverting input channel B
OUT A	1	Output	Output channel A
OUT B	7	Output	Output channel B
V-	4	Power	Negative supply
V+	8	Power	Positive supply



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1) (2)

				MIN	MAX	UNIT
	Differential input voltage				±Supply voltage	V
Vs	Supply voltage, V _S = (V+)) – (V–)		0	16	V
	Outrout aloant sinsuit	To V+			See ⁽³⁾	A
I _{SC}	Output short circuit	To V-			See ⁽⁴⁾	mA
	Current at input pin				±5	
	Current at output pin	Current at output pin			±18	mA
	Current at power supply p	oin			35	mA
TJ	Junction temperature ⁽⁵⁾				150	°C
T _{stg}	Storage temperature			-65	150	°C
	Lead temperature (solder	ing, 10s)			260	°C

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/Distributors for availability and specifications.
- 3) Do not connect output to V+, when V+ is greater than 13V or reliability is adversely affected.
- (4) Applies to both single-supply and split-supply operation. Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C. Output currents in excess of ±30mA over long term adversely affect reliability.
- (5) The maximum power dissipation is a function of $T_{J(max)}$, θ_{JA} , and T_A . The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(max)} T_A) / \theta_{JA}$.

5.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM) ⁽¹⁾	2000	V
V _(ESD)	Electrostatic discharge	Machine model	300	\ \ \

⁽¹⁾ Human body model, $1.5k\Omega$ in series with 100pF.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
V _S	Supply voltage, $V_S = (V+) - (V-)$	2	15.5	V
T _J	Junction temperature	-40	85	°C

5.4 Thermal Information

		LMC6035-Q1	
	THERMAL METRIC ⁽¹⁾	D (SOIC)	UNIT
		8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	175	°C/W
R ₀ JC(top)	Junction-to-case(top) thermal resistance	N/A	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	N/A	°C/W
ΨЈТ	Junction-to-top characterization parameter	N/A	°C/W
ΨЈВ	Junction-to-board characterization parameter	N/A	°C/W
R _{0JC(bot)}	Junction-to-case(bottom) thermal resistance	N/A	°C/W

⁽¹⁾ For information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

資料に関するフィードバック(ご意見やお問い合わせ)を送信

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English Data Sheet: SBOSAM6



5.5 Electrical Characteristics

at T_J = +25°C, V+ = 2.7V, V- = 0V, V_{CM} = 1V, V_{OUT} = V+ / 2, and R_L > 1M Ω (unless otherwise noted)

PARAMETER		TEST CO	MIN ⁽¹⁾	TYP ⁽²⁾	MAX ⁽¹⁾	UNIT	
OFFSET	VOLTAGE						
Vos	Input offset voltage				0.5	5	mV
vos	input onset voltage	$T_J = -40$ °C to +85°C				6	IIIV
dV _{OS} /dT	Input offset voltage drift	$T_J = -40$ °C to +85°C			2.3		μV/°C
		Positive,		63	93		
	Power-supply rejection	5V ≤ V+ ≤ 15V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	60			
PSRR	ratio	Negative,		74	97		dB
		$0V \le V - \le -10V$, $V_0 = 2.5V$, $V + = 5V$	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	70			
INPUT B	IAS CURRENT						
					20		fA
I _B	Input bias current ⁽³⁾	T _J = -40°C to +85°C				90	pA
	-				10		fA
Ios	Input offset current ⁽³⁾	T _J = -40°C to +85°C				45	pA
NOISE							•
e _n	Input voltage noise density	V _{CM} = 1V, f = 1kHz			27		nV/√ Hz
i _n	Input current noise density	f = 1kHz			0.2		fA/√ Hz
THD	Total harmonic distortion	f = 10kHz, G = -10V/V, R_L = 2k $Ω$, V _{OUT} = 8V _{pp} , V+ = 10V		0.01		%
INPUT V	OLTAGE	II.					
		To positive rail, For CMRR ≥ 40dB		2.0	2.3		
			$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	1.7			
		To negative rail			-0.1	0.3	
		For CMRR ≥ 40dB	$T_J = -40$ °C to +85°C		,	0.5	
		To positive rail, For CMRR ≥ 40dB, V+ = 3V		2.3	2.6		
			$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	2.0			
		To negative rail			-0.3	0.1	
.,	0	For CMRR ≥ 40dB, V+ = 3V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$			0.3	V
V _{CM}	Common-mode voltage	To positive rail,		4.2	4.5		V
		For CMRR ≥ 50dB, V+ = 5V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	3.9			
		To negative rail			-0.5	-0.2	
		For CMRR ≥ 50dB, V+ = 5V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$			0.0	
		To positive rail,		14.0	14.4		
		For CMRR ≥ 50dB, V+ = 15V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	13.7			
		To negative rail			-0.5	-0.2	
		For CMRR ≥ 50dB, V+ = 15V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$			0.0	
CMRR	Common-mode rejection	V+ = 15V,		63	96		40
CIVIKK	ratio	$0.7V \le V_{CM} \le 12.7V$	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	60			dB
INPUT IN	IPEDANCE						
R _{IN}	Input resistance				>10		ΤΩ



5.5 Electrical Characteristics (続き)

at T $_J$ = +25°C, V+ = 2.7V, V- = 0V, V $_{CM}$ = 1V, V $_{OUT}$ = V+ / 2, and R $_L$ > 1M Ω (unless otherwise noted)

	PARAMETER	TEST COM	NDITIONS	MIN ⁽¹⁾	TYP ⁽²⁾	MAX ⁽¹⁾	UNIT	
OPEN-L	OOP GAIN							
			$R_L = 2k\Omega$ to 7.5V		2000			
		Sourcing, V+ = 15V, V _{CM} = 7.5V,	$R_L = 600\Omega$ to 7.5V	100	1000			
		$7.5V \le V_{O} \le 11.5V$	R_L = 600Ω to to 7.5V, T_J = -40°C to +85°C	75				
A _V	Large signal voltage gain		$R_L = 2k\Omega$ to 7.5V		500		V/mV	
		Sinking, V+ = 15V, V _{CM} = 7.5V,	$R_L = 600\Omega$ to 7.5V	25	250			
		$3.5V \le V_O \le 7.5V$	$R_L = 600\Omega$ to 7.5V, $T_J = -40^{\circ}$ C to +85°C	20				
FREQU	ENCY RESPONSE							
GBW	Gain bandwidth product				1.4		MHz	
SR	Slew rate ⁽⁴⁾	V _S = 15V, 10V step, g = 1			1.5		V/µs	
θ_{m}	Phase margin				48		0	
G _m	Gain margin				17		dB	
	Crosstalk	Dual and quad channel, V+ = 15V V _{OUT} = 12V _{pp}	f , $R_L = 100 \text{k}\Omega$ to 7.5V, $f = 1 \text{kHz}$,		130		dB	
OUTPU	Т							
		To positive rail,		2.4	2.62			
		$R_L = 2k\Omega$ to 1.35V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	2.2				
		To negative rail,			0.07	0.2		
		$R_L = 2k\Omega$ to 1.35V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$			0.4		
		To positive rail, R _L = 600Ω to $1.35V$		2.0	2.5			
			$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	1.8			V	
		To negative rail, R _L = 600Ω to $1.35V$			0.2	0.5		
			$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$			0.7		
Vo	Voltage output swing	To positive rail, V+ = 15V, R_L = 2k Ω to 7.5V		14.2	14.8			
			T _J = -40°C to +85°C	13.5				
		To negative rail,			0.12	0.4		
		V+ = 15V, R_L = 2kΩ to 7.5V	T _J = -40°C to +85°C			0.5		
		To positive rail,		13.5	14.5			
		$V + = 15V$, $R_L = 600\Omega$ to 7.5V	T _J = -40°C to +85°C	13.0				
		To negative rail,			0.36	1.25		
		$V + = 15V$, $R_L = 600\Omega$ to 7.5V	T _J = -40°C to +85°C			1.50		
		Sourcing,		4	8			
		V _{OUT} = 0V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	3			mA	
Io	Output current			3	5			
		Sinking, V _{OUT} = 2.7V	$T_{J} = -40^{\circ}\text{C to } +85^{\circ}\text{C}$	2			+	
POWER	R SUPPLY		0					
					0.65	1.6		
Is	Supply current	V _{OUT} = 1.5V	$T_J = -40^{\circ}\text{C to } +85^{\circ}\text{C}$			1.9	mA	

⁽¹⁾ All limits are specified by testing or statistical analysis.

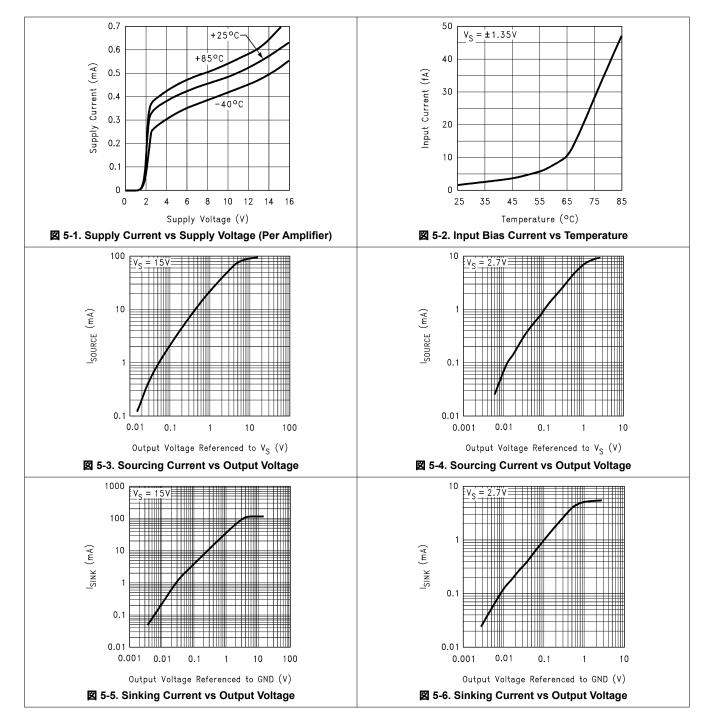
⁽²⁾ Typical values represent the most likely parametric norm or one sigma value.

⁽³⁾ Specified by design.

⁽⁴⁾ Number specified is the slower of the positive and negative slew rates.

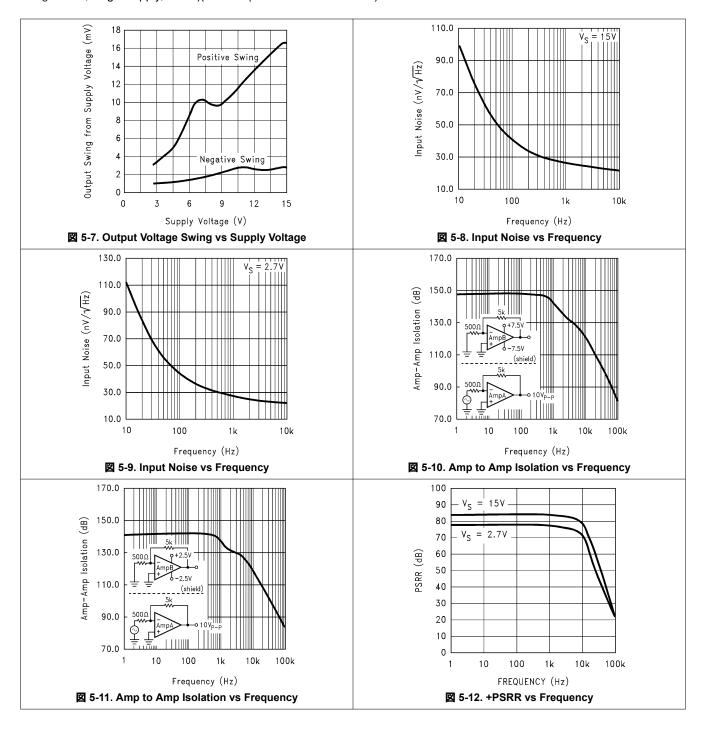
5.6 Typical Characteristics

at V_S = 2.7V, single supply, and T_A = 25°C (unless otherwise noted)

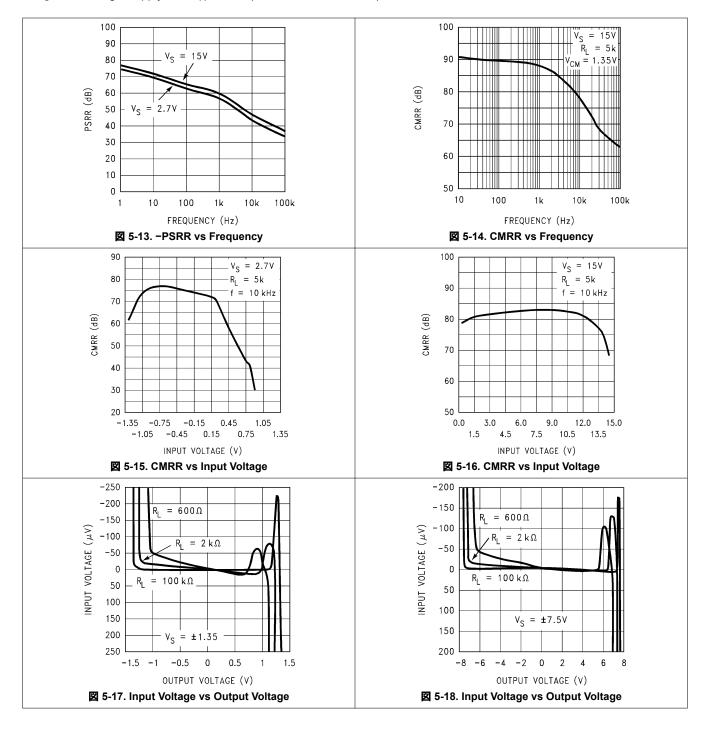


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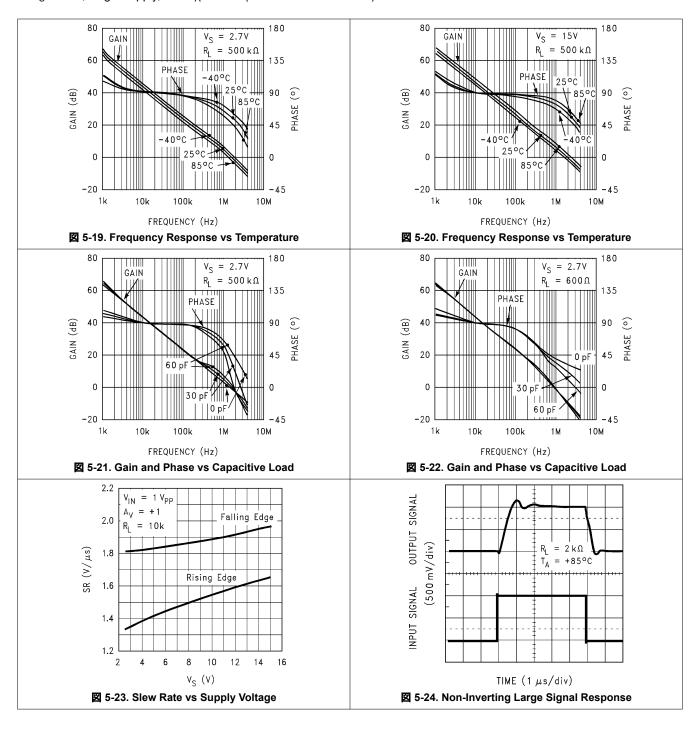


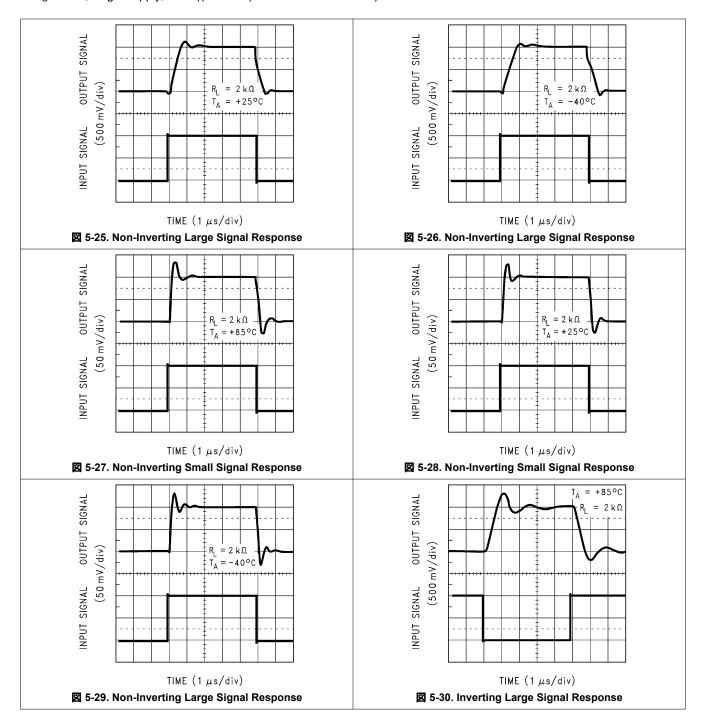




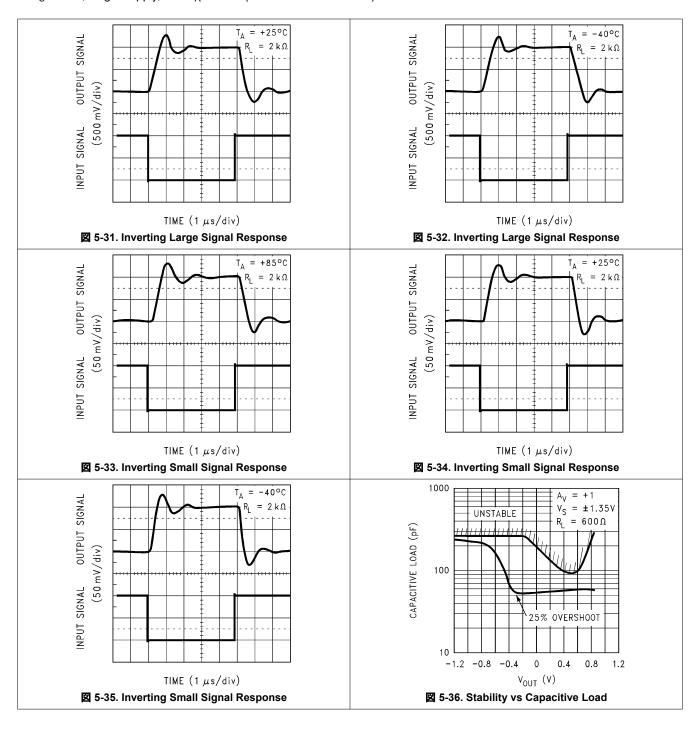




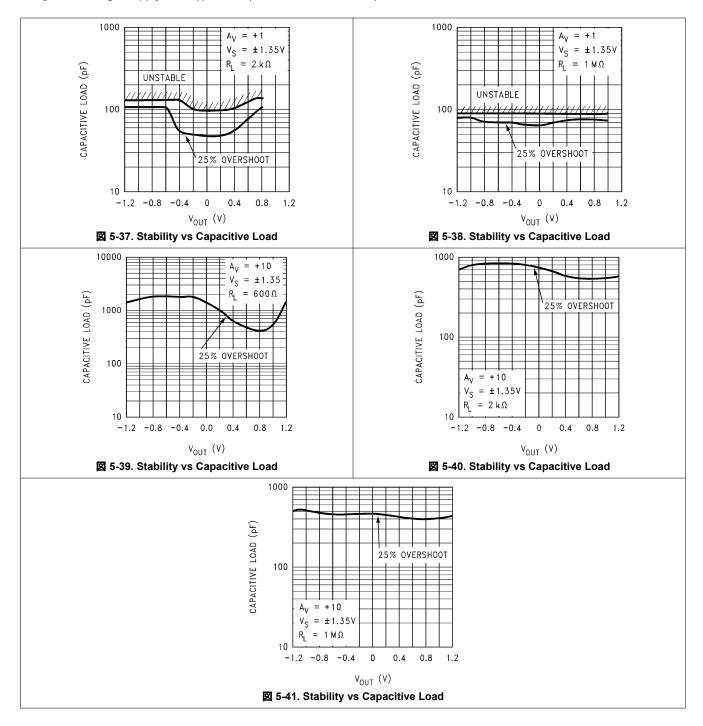










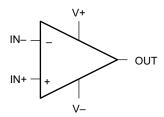


6 Detailed Description

6.1 Overview

The LMC6035-Q1 operational amplifiers are designed to provide very low leakage current. The femtoampere leakage current level makes these op amps an excellent choice for buffering very high impedance sources. The LMC6035-Q1 is capable of operating over a wide supply voltage range and as low as 2V. The low supply operation and AEC-Q100 Grade 3 qualification make the LMC6035-Q1 an excellent choice for a wide range of automotive applications.

6.2 Functional Block Diagram



7 Application and Implementation

注

以下のアプリケーション情報は、TIの製品仕様に含まれるものではなく、TIではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくことになります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

7.1 Application Information

7.1.1 Capacitive Load Tolerance

Like many other op amps, the LMC6035-Q1 can oscillate when the applied load appears capacitive. The threshold of oscillation varies both with load and circuit gain. The configuration most sensitive to oscillation is a unity-gain follower. See also セクション 5.6.

The load capacitance interacts with the op amp output resistance to create an additional pole. If this pole frequency is sufficiently low, the pole degrades the op amp phase margin so that the amplifier is no longer stable at low gains. \boxtimes 7-1 shows that the addition of a small resistor (50Ω to 100Ω) in series with the op amp output, and a capacitor (5pF to 10pF) from inverting input to output pins, returns the phase margin to a safe value without interfering with lower-frequency circuit operation. Thus, larger values of capacitance can be tolerated without oscillation. In all cases, the output rings heavily when the load capacitance is near the threshold for oscillation.

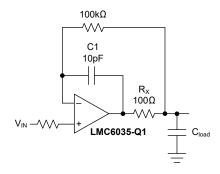


図 7-1. Rx, Cx Improve Capacitive Load Tolerance

Capacitive load driving capability is enhanced by using a pullup resistor to V+ (shown in 🗵 7-2). Typically a pullup resistor conducting 500µA or greater significantly improves capacitive-load responses. The value of the pullup resistor is determined based on the current sinking capability of the amplifier with respect to the desired output swing. The open-loop gain of the amplifier can also be affected by the pullup resistor (see the *Electrical Characteristics*).

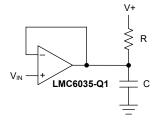


図 7-2. Compensating for Large Capacitive Loads With a Pullup Resistor

7.2 Typical Applications

7.2.1 Differential Driver

The LMC6035-Q1 is an excellent choice for low-voltage applications. A desirable feature that the LMC6035-Q1 brings to low-voltage applications is the output drive capability—a hallmark for Tl's CMOS amplifiers. The circuit of \boxtimes 7-3 illustrates the drive capability of the LMC6035-Q1 at 3V of supply. These devices are used as a differential output driver for a one-to-one audio transformer, like those used for isolating ground from the telephone lines. The transformer (T1) loads the op amps with about 600 Ω of ac load, at 1kHz. Capacitor C1 functions to block dc from the low winding resistance of T1. Although the value of C1 is relatively high, the capacitive load reactance (X_C) is negligible compared to inductive reactance (X_I) of T1.

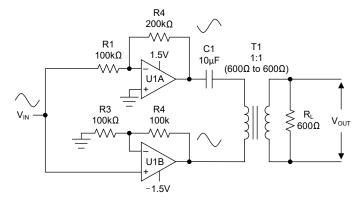
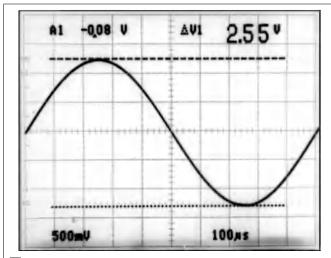


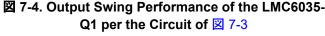
図 7-3. Differential Driver

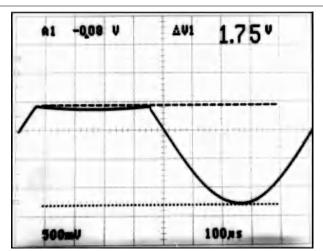
The circuit in \boxtimes 7-3 consists of one input signal and two output signals. U1A amplifies the input with an inverting gain of -2, while the U1B amplifies the input with a non-inverting gain of +2. The two outputs are 180° out of phase with each other; therefore, the gain across the differential output is 4. As the differential output swings between the supply rails, one of the op amps sources the current to the load, while the other op amp sinks the current.

How good a CMOS op amp can sink or source a current is an important factor in determining output swing capability. The output stage of the LMC6035-Q1—like many op amps—sources and sinks output current through two complementary transistors in series. This *totem pole* arrangement translates to a channel resistance (R_{dson}) at each supply rail that acts to limit the output swing. Most CMOS op amps are able to swing the outputs very close to the rails; except, however, under the difficult conditions of low supply voltage and heavy load. The LMC6035-Q1 exhibits exceptional output swing capability under these conditions.

The scope photos of \boxtimes 7-4 and \boxtimes 7-5 represent measurements taken directly at the output (relative to GND) of U1A, in \boxtimes 7-3. \boxtimes 7-4 illustrates the output swing capability of the LMC6035-Q1, while \boxtimes 7-5 provides a benchmark comparison. (The benchmark op amp is another low-voltage (3V) op amp manufactured by one of our reputable competitors.)







☑ 7-5. Output Swing Performance of Benchmark
Op Amp per the Circuit of ☑ 7-3

Notice the excellent drive capability of LMC6035-Q1 when compared with the benchmark measurement—even though the benchmark op amp uses twice the supply current.

Not only does the LMC6035-Q1 provide excellent output swing capability at low supply voltages, but these devices also maintain high open-loop gain (A $_{OL}$) with heavy loads. To illustrate this, the LMC6035-Q1 and the benchmark op amp were compared for distortion performance in the circuit of \boxtimes 7-3. \boxtimes 7-6 shows this comparison. The y-axis represents percent total harmonic distortion (THD + noise) across the loaded secondary of T1. The x-axis represents the input amplitude of a 1kHz sine wave. (Notice that T1 loses about 20% of the voltage to the voltage divider of R_L (600 Ω) and T1 winding resistances—a performance deficiency of the transformer.)

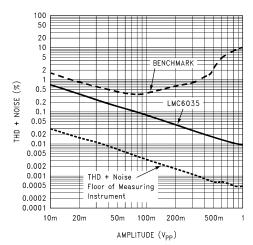


図 7-6. THD+Noise Performance of LMC6035-Q1 and Benchmark per Circuit of 図 7-3

 \boxtimes 7-6 shows the excellent distortion performance of the LMC6035-Q1 over that of the benchmark op amp. The heavy loading of the circuit causes the A_{OL} of the benchmark part to drop significantly, which causes increased distortion.



7.2.2 Low-Pass Active Filter

A common application for low voltage systems is active filters, in cordless and cellular phones for example. The ultra low input bias currents (I_B) of the LMC6035-Q1 makes this op amp an excellent for low power active filter applications, because the low input bias current allows the use of higher resistor values and lower capacitor values. This reduces power consumption and space.

 \boxtimes 7-7 shows a low pass, active filter with a Butterworth (maximally flat) frequency response. The topology is a Sallen and Key filter with unity gain. Note the normalized component values in parenthesis which are obtainable from standard filter design handbooks. These values provide a 1Hz cutoff frequency, but can be easily scaled for a desired cutoff frequency (f_c). The bold component values of \boxtimes 7-7 provide a cutoff frequency of 3kHz. An example of the scaling procedure follows \boxtimes 7-7.

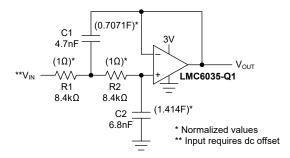


図 7-7. 2-Pole, 3kHz, Active, Sallen and Key, Low-Pass Filter With Butterworth Response

7.2.2.1 Low-Pass Frequency Scaling Procedure

The actual component values represented in bold of Z 7-7 were obtained with the following scaling procedure:

 First determine the frequency scaling factor (FSF) for the desired cutoff frequency. Choosing f_c at 3kHz, provides the following FSF computation:

$$FSF = 2\pi \times 300 \text{kHz} = 18.84 \text{k} \tag{1}$$

2. Then divide all of the normalized capacitor values by the FSF as follows (C1' and C2': prior to impedance scaling):

$$C1' = \frac{C1_{\text{normalized}}}{FSF} = \frac{0.707}{18.84k} = 37.93 \times 10^{-6} F$$
 (2)

$$C2' = \frac{C1_{\text{normalized}}}{FSF} = \frac{1.414}{18.84k} = 75.05 \times 10^{-6} F$$
 (3)

3. Last, choose an impedance scaling factor (Z). This Z factor can be calculated from a standard value for C2. Then Z can be used to determine the remaining component values as follows:

$$Z = \frac{C2'}{C2_{\text{chosen}}} = \frac{75.05 \times 10^{-6} \text{F}}{6.8 \text{nF}} = 8.4 \text{k}$$
 (4)

$$C1 = \frac{C1'}{Z} = \frac{37.93 \times 10^{-6} \text{F}}{8.4 \text{k}} = 4.52 \text{nF}$$
 (5)

$$R1 = R1_{\text{normalized}} \times Z = 1\Omega \times 8.4k = 8.4k\Omega$$
 (6)

$$R2 = R2_{\text{normalized}} \times Z = 1\Omega \times 8.4k = 8.4k\Omega \tag{7}$$

4. A standard value of $8.45k\Omega$ is chosen for R1 and R2.

7.2.3 High-Pass Active Filter

The previous low-pass filter circuit of \boxtimes 7-7 converts to a high-pass active filter per \boxtimes 7-8.

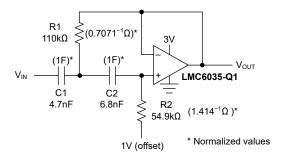


図 7-8. 2-Pole, 300Hz, Sallen and Key, High-Pass Filter

7.2.3.1 High-Pass Frequency Scaling Procedure

Choose a standard capacitor value and scale the impedances in the circuit according to the desired cutoff frequency (300Hz) as follows:

$$C = C1 = C2 \tag{8}$$

$$Z = \frac{1}{2\pi f_c C} = \frac{1}{2\pi \times 300 \text{Hz} \times 6.8 \text{nF}} = 78.05 \text{k}\Omega$$
 (9)

$$R1 = Z \times R1_{\text{normalized}} = 78.05 \text{k}\Omega \times \frac{1}{0.707} = 110.4 \text{k}\Omega$$
 (10)

A standard value of $110k\Omega$ is chosen for R1.

$$R2 = Z \times R2_{\text{normalized}} = 78.05 \text{k}\Omega \times \frac{1}{1.414} = 55.2 \text{k}\Omega$$
 (11)

A standard value of $54.9k\Omega$ is chosen for R2.

English Data Sheet: SBOSAM6



7.2.4 Dual-Amplifier Bandpass Filter

The dual-amplifier bandpass (DABP) filter features the ability to independently adjust f_c and Q. In most other bandpass topologies, the f_c and Q adjustments interact with each other. The DABP filter also offers both low sensitivity to component values and a high Q. The following application of \boxtimes 7-9, provides a 1kHz center frequency and a Q of 100.

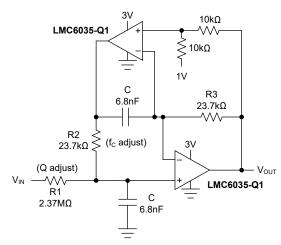


図 7-9. Active 2-Pole Bandpass Filter (1kHz)

7.2.4.1 DABP Component Selection Procedure

Component selection for the DABP filter is performed as follows:

1. First choose a center frequency (f_c). ☑ 7-9 represents component values that were obtained from the following computation for a center frequency of 1kHz.

$$R2 = R3 = \frac{1}{2\pi f_c C}$$
 (12)

Given that $f_c = 1kHz$ and $C_{(chosen)} = 6.8nF$:

$$R2 = R3 = \frac{1}{2\pi \times 1 \text{kHz} \times 6.8 \text{nF}} = 23.4 \text{k}\Omega$$
 (13)

A standard value resistor, $23.7k\Omega$ is chosen.

2. Then compute R1 for a desired Q (f_c / BW) as follows:

$$R1 = Q \times R2 \tag{14}$$

Choosing a Q of 100, the resistor R1 can be computed as follows: $R1 = 100 \times 23.7 \text{k}\Omega = 2.37 \text{M}\Omega$ (15)

7.3 Layout

7.3.1 Layout Guidelines

7.3.1.1 Printed Circuit Board (PCB) Layout for High-Impedance Work

Any circuit that must operate with < 1000pA of leakage current requires special layout of the PCB. To take advantage of the ultra-low bias current of the LMC6035-Q1 (typically < 0.04pA), an excellent layout is essential. Fortunately, the techniques for obtaining low leakages are quite simple. First, do not ignore the surface leakage of the PCB, even though at times the surface leakage can appear acceptably low. Under conditions of high humidity, dust, or contamination, the surface leakage can be appreciable.

To minimize the effect of any surface leakage, lay out a ring of foil completely surrounding the LMC6035-Q1 inputs and the terminals of capacitors, diodes, conductors, resistors, relay terminals, and so on, connected to the op-amp inputs. See also \boxtimes 7-14. To have a significant effect, place guard rings on both the top and bottom of the PCB. This PCB foil must then be connected to a voltage that is at the same voltage as the amplifier inputs (because no leakage current can flow between two points at the same potential). For example, a PCB trace-to-pad resistance of $10^{12}\Omega$, which is normally considered a very large resistance, can leak 5pA if the trace is a 5V bus adjacent to the pad of an input. This configuration can cause a 100 times degradation from the actual performance of the amplifier. However, if a guard ring is held within 5mV of the inputs, then even a resistance of $10^{11}\Omega$ causes only 0.05pA of leakage current, or perhaps a minor (2:1) degradation of the amplifier performance. See \boxtimes 7-10 through \boxtimes 7-12 for typical connections of guard rings for standard op-amp configurations. If both inputs are active and at high impedance, the guard can be tied to ground and still provide some protection; see also \boxtimes 7-13.

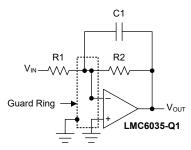


図 7-10. Guard Ring Connections: Inverting Amplifier

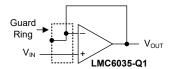


図 7-12. Guard Ring Connections: Follower

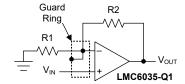


図 7-11. Guard Ring Connections: Noninverting
Amplifier

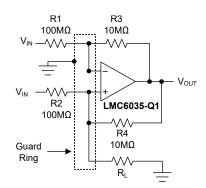


図 7-13. Howland Current Pump

A more comprehensive discussion on high impedance circuit design and considerations, see also *Measurement and Calibration Techniques for Ultra-low Current Measurement Systems* application note.



7.3.2 Layout Example

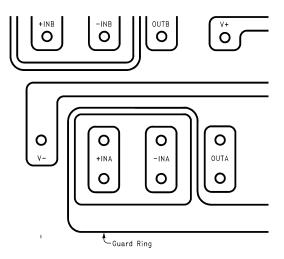


図 7-14. Layout Example: Using the LMC6035-Q1 Guard Ring in PCB Layout

8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jp のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。 変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

8.2 サポート・リソース

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ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

8.4 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

9 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision SNOS875G (April 2013) to Revision * (December 2024)	Page
・ ドキュメント全体にわたって表、図、相互参照の採番方法を更新	1
• 「ピン構成および機能」、「仕様」、「ESD 定格」、「推奨動作条件」、「熱に関する情報」、「詳細説明」、「私	既要」、「機能
ブロック図」、「デバイスの機能モード」、「アプリケーションと実装」、「代表的なアプリケーション」、「電源「	に関する推奨
事項」、「レイアウト」、「レイアウトのガイドライン」、「熱に関する考慮事項」、「デバイスおよびドキュメントの	ク <i>サポート」、</i>
「メカニカル、パッケージ、および注文情報」セクションを追加しました	1
• LMC6035-Q1 を SBOS875G から SBOSAM6 に移動	1
• 「特長」を更新	1
• 「 <i>概要」を更新</i>	1
• 図 1 8 バンプ DSBGA パッケージを削除	
• RES11 イメージを使った差動アンプのアプリケーションを追加しました	
Updated figures and tables in Pin Configuration and Functions	
Updated parameter names and symbols	5
Moved previous table note 4 into open-loop gain test conditions	5
• Updated previous table note 2 from AC Electrical Characteristics and moved conditions to slew r	ate
test conditions	5

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資料に関するフィードバック(ご意見やお問い合わせ)を送信



•	Moved previous table note 3 from AC Electrical Characteristics to crosstalk test conditions	5
	Changed A _{VOL} to A _{OL}	
	Updated Figure 7-7	
	Updated Figure 7-8	
	Updated Figure 7-9	
•	Added reference to Measurement and Calibration Techniques for Ultra-low Current Measurement System application note in Printed Circuit Board (PCB) Layout for High-Impedance Work	s

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
LMC6035IMXQ1	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	LMC60 35IMQ
LMC6035IMXQ1.A	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	LMC60 35IMQ
LMC6035IMXQ1.B	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	LMC60 35IMQ

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

www.ti.com 7-Nov-2025

OTHER QUALIFIED VERSIONS OF LMC6035-Q1:

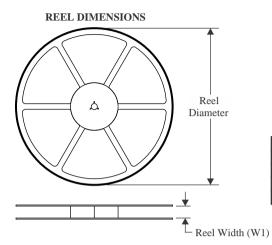
NOTE: Qualified Version Definitions:

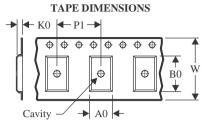
• Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

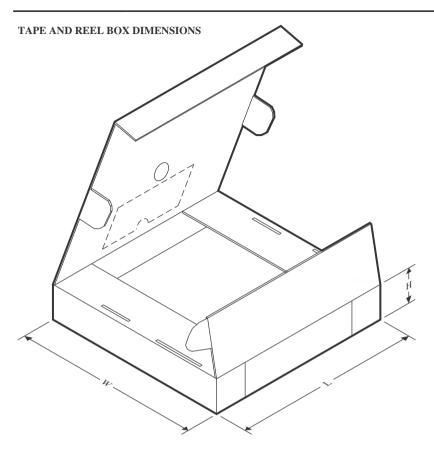
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	U	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMC6035IMXQ1	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
LMC6035IMXQ1	SOIC	D	8	2500	367.0	367.0	35.0	



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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最終更新日: 2025 年 10 月